

This Verification of Compliance is hereby issued to the product designated below.

**Product** Switching Power Supply

Model 500 BR

Data Applies To 450 BR

**Brand** EVGA

Applicant EVGA Corporation

18F., No.176, Jian 1st Rd., Zhonghe Dist., New Taipei City,

Taiwan

Manufacturer EVGA Corporation

18F., No.176, Jian 1st Rd., Zhonghe Dist., New Taipei City,

Taiwan

Applicable

EN 55032: 2012+AC: 2013, Class B

**Standard(s)** EN 61000-3-2: 2014, EN 61000-3-3: 2013

EN 55024: 2010

IEC 61000-4-2: 2008, IEC 61000-4-3: 2010, IEC 61000-4-4: 2012 IEC 61000-4-5: 2014, IEC 61000-4-6: 2013, IEC 61000-4-8: 2009

IEC 61000-4-11: 2004+A1: 2017

Reference No. T180226N02-E

Test Laboratory Compliance Certification Services Inc.

**Tainan Laboratory** 

No.8, Jiucengling, Xinhua Dist., Tainan City 712, Taiwan (R.O.C.)

http://www.ccsrf.com service@ccsrf.com

This device has been tested and found to comply with the stated standard, which is required by the Council Directive of 2014/30/EU. The test results are indicated in the test report and are applicable only to the tested sample identified in the report.

Jeter Wu / Assistant Manager

Tainan Lab

Date: March 31, 2018



Page 1 of 77 Rev.00

# EMC COMPLIANCE TEST REPORT

for

**Switching Power Supply** 

Model: 500 BR

Data Applies To: 450 BR

**Brand: EVGA** 

Test Report Number: T180226N02-E

Issued to:

# **EVGA Corporation**

18F., No.176, Jian 1st Rd., Zhonghe Dist., New Taipei City, Taiwan

Issued by:

**Compliance Certification Services Inc.** 

**Tainan Laboratory** 

No.8, Jiucengling, Xinhua Dist., Tainan City 712, Taiwan (R.O.C.)

TEL: 886-6-5802201

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Issued Date: March 23, 2018





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Page 2 of 77 Rev.00

# **REVISION HISTORY**

Rev.	Issue Date	Revisions	Effect Page	Revised By
00	March 23, 2018	Initial Issue	ALL	Gina Lin



Page 3 of 77 Rev.00

# **TABLE OF CONTENTS**

I	TEST CERTIFICATION	4
2	TEST RESULT SUMMARY	5
3	EUT DESCRIPTION	6
4	TEST METHODOLOGY	7
	4.1. DECISION OF FINAL TEST MODE	7
	4.2. EUT SYSTEM OPERATION	7
5	SETUP OF EQUIPMENT UNDER TEST	8
	5.1. DESCRIPTION OF SUPPORT UNITS	8
	5.2. CONFIGURATION OF SYSTEM UNDER TEST	8
6	FACILITIES AND ACCREDITATIONS	9
	6.1. FACILITIES	9
	6.2. ACCREDITATIONS	
	6.3. MEASUREMENT UNCERTAINTY	
7	EMISSION TEST	. 11
	7.1. CONDUCTED EMISSION MEASUREMENT	11
	Test Voltage: AC 230V, 50Hz	
	7.2. CONDUCTED EMISSION MEASUREMENT AT ANALOGUE/DIGITAL DATA PORTS .	
	7.3. RADIATED EMISSION MEASUREMENT	
	7.5. VOLTAGE FLUCTUATION AND FLICKER MEASUREMENT	
8		
•	8.1. GENERAL DESCRIPTION	
	8.2. GENERAL PERFORMANCE CRITERIA DESCRIPTION	
	8.3. ELECTROSTATIC DISCHARGE (ESD)	
	8.4. RADIATED, RADIO-FREQUENCY, ELECTROMAGNETIC FIELD (RS)	
	8.5. ELECTRICAL FAST TRANSIENT (EFT)	
	8.6. SURGE IMMUNITY TEST	
	8.7. CONDUCTED RADIO FREQUENCY DISTURBANCES (CS)	
	8.9. VOLTAGE DIPS & VOLTAGE INTERRUPTIONS	
9		
Α	\PPENDIX 1 – PHOTOGRAPHS OF EUT	A1



Page 4 of 77 Rev.00

# 1 TEST CERTIFICATION

**Product:** Switching Power Supply

Model: 500 BR

Data Applies To: 450 BR

**Brand:** EVGA

**Applicant: EVGA Corporation** 

18F., No.176, Jian 1st Rd., Zhonghe Dist., New Taipei City, Taiwan

**Manufacturer: EVGA Corporation** 

18F., No.176, Jian 1st Rd., Zhonghe Dist., New Taipei City, Taiwan

**Tested:** March 02, 2018 ~ March 16, 2018

**Applicable EN 55032: 2012+AC: 2013, EN 55024: 2010 Standards: Class B**IEC 61000-4-2: 2008

EN 61000-3-2: 2014 IEC 61000-4-3: 2010 IEC 61000-4-4: 2012 IEC 61000-4-5: 2014

IEC 61000-4-6: 2013 IEC 61000-4-8: 2009

IEC 61000-4-11: 2004+A1: 2017

# **Deviation from Applicable Standard**

None

The above equipment was tested by Compliance Certification Services Inc. for compliance with the requirements of technical standards specified above under the EMC Directive 2014/30/EU. The results of testing in this report apply only to the product/system, which was tested. Other similar equipment will not necessarily produce the same results due to production tolerance and measurement uncertainties.

Approved by:

Reviewed by:

Jeter Wu

Assistant Manager

Eric Huang Section Manager



Page 5 of 77 Rev.00

# 2 TEST RESULT SUMMARY

EMISSION						
Standard	Item	Result	Remarks			
	Conducted (Power Port)	PASS	Meet Class B limit			
EN 55032: 2012+AC: 2013	Conducted (Analogue/Digital Data Ports)	N/A	No requirement			
	Radiated (Below 1GHz)	PASS	Meet Class B limit			
	Radiated (Above 1GHz)	N/A	No requirement			
EN 61000-3-2: 2014	Harmonic current emissions	PASS	Meet the requirement			
EN 61000-3-3: 2013	Voltage fluctuations & flicker	PASS	Meet the requirement			

IMMUNITY [ EN 55024: 2010]						
Standard	Item	Result	Remarks			
IEC 61000-4-2: 2008	ESD	PASS	Meets the requirements of Performance Criterion A			
IEC 61000-4-3: 2010	RS	PASS	Meets the requirements of Performance Criterion A			
IEC 61000-4-4: 2012	EFT	PASS	Meets the requirements of Performance Criterion A			
IEC 61000-4-5: 2014	Surge	PASS	Meets the requirements of Performance Criterion A			
IEC 61000-4-6: 2013	CS	PASS	Meets the requirements of Performance Criterion A			
IEC 61000-4-8: 2009	PFMF	PASS	Meets the requirements of Performance Criterion A			
IEC 61000-4-11: 2004+A1: 2017	Voltage dips & voltage variations	PASS	Meets the requirements of  Voltage Dips:  1) >95% reduction Performance Criterion A  2) 30% reduction Performance Criterion A  Voltage Interruptions:  1) >95% reduction Performance Criterion B			

# Note:

- 1. The statements of test result on the above are decided by the request of test standard only; the measurement uncertainties are not factored into this compliance determination.
- 2. The information of measurement uncertainty is available upon the customer's request.



Page 6 of 77 Rev.00

# 3 EUT DESCRIPTION

Product	Switching Power Supply
Model	500 BR
Data Applies To	450 BR
Brand Name	EVGA
Applicant	EVGA Corporation
Manufacture	EVGA Corporation
Housing material	Metal case
Identify Number	T180226N02
Received Date	February 26, 2018
EUT Power Rating	AC 100-240V, 8-4A, 50-60Hz
EUT Size (L*W*H)	15*14*8.5 (cm)

# I/O PORT

I/O PORT TYPES	Q'TY	TESTED WITH
AC Input Power	1	AC Source

#### Note:

- 1. Client consigns one model sample to test (Model Number: **500 BR**). Therefore, the testing Lab. Just guarantees the unit, which has been tested.
- 2. For more details, please refer to the User's manual of the EUT.
- 3. The listed model (450 BR) is identical with the original model (500 BR), except for the different model name and output voltage are just for the marketing purpose.

Model∂			Ra	ted Ou	ıtput₽		Max. p	ower₽		
	Inputℯ	+5V <i>₽</i>	+3.3 V	+12 V₽	-12V∉	+5Vsb⊹	+5V·&· +3.3V∂		total output power∉	•
500-BR₽	100-240V~,	20₽	20₽	41.7₽	0.3₽	3.0₽	120₽	500₽	500₽	30₽
	50-60Hz, <sub></sub>									
	8-4A <i>₽</i>									
450 BR₽	100-240V~,	20₽	20₽	37.5₽	0.3₽	3.0₽	120₽	450₽	450₽	30₽
	50-60Hz, <sub></sub>									
	8-4A <i>₽</i>									



Page 7 of 77 Rev.00

# 4 TEST METHODOLOGY

# 4.1. DECISION OF FINAL TEST MODE

The EUT was tested together with the above additional components, and a configuration, which produced the worst emission levels, was selected and recorded in this report.

The test configuration/ modes are as the following:

Cond	luction (Power port) Modes:	
1.	Full Load	
Cond	luction (Analogue/Digital Data Ports)	Modes
1.	Non	
Radi	ation Modes: (Below 1GHz)	
1.	Full Load	
Imm	unity Mode:	
1.	Full Load	

# 4.2. EUT SYSTEM OPERATION

- 1. Setup a whole system for test as shown on setup diagram.
- 2. Turn on power and check function.
- 3. Start to test by test mode.



Page 8 of 77 Rev.00

# 5 SETUP OF EQUIPMENT UNDER TEST

# 5.1. DESCRIPTION OF SUPPORT UNITS

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

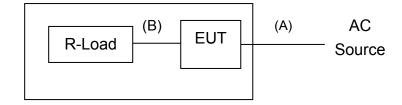
No.	Product	Manufacturer	Model No.	Certify No.	Signal cable
1			N/A	N/A	N/A

No.	Signal cable description	
Α	AC IN Power	Unshielded, 1.6m, 1 pcs
В	DC OUT Power	Unshielded, 1.0m, 4 pcs

#### Note:

- 1. All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.
- 2. Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.
- 3. shd. = shielded; unshd. = unshielded

# 5.2. CONFIGURATION OF SYSTEM UNDER TEST





Page 9 of 77 Rev.00

# 6 FACILITIES AND ACCREDITATIONS

# 6.1. FACILITIES

All measurement facilities used to collect the measurement data are located at CCS Taiwan Tainan Laboratory at

No.8, Jiucengling, Xinhua Dist., Tainan City 712, Taiwan (R.O.C.)

The sites are constructed in conformance with the requirements of ANSI C63.4 and CISPR Publication 22. All receiving equipment conforms to CISPR 16-1-1, CISPR 16-1-2, CISPR 16-1-3, CISPR 16-1-4 and CISPR 16-1-5.

# 6.2. ACCREDITATIONS

Our laboratories are accredited and approved by the following accreditation body according to ISO/IEC 17025.

**Taiwan** TAF

The measuring facility of laboratories has been authorized or registered by the following approval agencies.

Canada Industry Canada

Germany TUV NORD

Taiwan BSMI USA FCC

Copies of granted accreditation certificates are available for downloading from our web site, http://www.ccsrf.com



Page 10 of 77 Rev.00

# **6.3. MEASUREMENT UNCERTAINTY**

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

Measur	ement	Frequency	Uncertainty	
Power Line Conducted Emission		9kHz~30MHz	±1.45dB	
Conduction	Emission	150kHz~30MHz	±1.35dB	
	Test Site : OATS-5	30 MHz ~200 MHz	±3.78dB	
	Test Site . UATS-5	200 MHz ~1000 MHz	±3.51dB	
Radiated Emission	Test Site : OATS-6	30 MHz ~200 MHz	±3.22dB	
(10m)	Test Site . UATS-0	200 MHz ~1000 MHz	±2.62dB	
	Test Site : OATS-7	30 MHz ~200 MHz	±3.50dB	
	Test Site . UATS-7	200 MHz ~1000 MHz	±3.18dB	
	Test Site : OATS-5	30 MHz ~200 MHz	±3.36dB	
	Test Site . UATS-5	200 MHz ~1000 MHz	±2.43dB	
	Toot Cito : OATC 6	30 MHz ~200 MHz	±3.48dB	
Radiated Emission (3m)	Test Site : OATS-6	200 MHz ~1000 MHz	±2.24dB	
	Toot Cito : OATC 7	30 MHz ~200 MHz ±3.47dB		
	Test Site : OATS-7	200 MHz ~1000 MHz	±2.62dB ±3.50dB ±3.18dB ±3.36dB ±2.43dB ±3.48dB ±2.24dB	
	Chamber 966	1000Mhz~6000MHz	±2.65dB	

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Consistent with industry standard (e.g. CISPR 22: 2008+I3: 2012, Measurement Uncertainty) determining compliance with the limits shall be base on the results of the compliance measurement. Consequently the measure emissions being less than the maximum allowed emission result in this be a compliant test or passing test.

The acceptable measurement uncertainty value without requiring revision of the compliance statement is base on conducted and radiated emissions being less than  $U_{CISPR}$  which is 3.6dB and 5.2dB respectively. CCS values (called  $U_{Lab}$  in CISPR 16-4-2) is less than  $U_{CISPR}$  as shown in the table above. Therefore, MU need not be considered for compliance.



Page 11 of 77 Rev.00

# 7 EMISSION TEST

# 7.1. CONDUCTED EMISSION MEASUREMENT

#### 7.1.1. **LIMITS**

EDECUENCY (MUL)	Class A	A (dBuV)	Class B (dBuV)		
FREQUENCY (MHz)	Quasi-peak	Average	Quasi-peak	Average	
0.15 - 0.5	79	66	66 - 56	56 - 46	
0.50 - 5.0	73	60	56	46	
5.0 - 30.0	73	60	60	50	

#### Note:

- 1. The lower limit shall apply at the transition frequencies.
- 2. The limit decreases in line with the logarithm of the frequency in the range of 0.15 to 0.50 MHz.
- 3. All emanations from a class A/B digital device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified above.

# 7.1.2. TEST INSTRUMENTS

	Conducted Emission room #1								
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due					
BNC Coaxial Cable	ccs	BNC50	11	01/23/2019					
EMI Test Receiver	Receiver R&S		100348	01/30/2019					
LISN	SCHWARZBECK	NNLK8130	8130124	11/30/2018					
LISN	FCC	FCC-LISN-50 -32-2	08009	05/07/2018					
Pulse Limiter	R&S	ESH3-Z2	100116	01/23/2019					
Software	e-3 (5.04211j)								

**Note:** The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.



Page 12 of 77 Rev.00

### 7.1.3. TEST PROCEDURES

#### **Procedure of Preliminary Test**

The EUT and Support equipment, if needed, was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per EN 55032 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor standing equipment, it is placed on the ground plane, which has a 15 cm non-conductive covering to insulate the EUT from the ground plane.

All I/O cables were positioned to simulate typical actual usage as per EN 55032.

The test equipment EUT installed received main power, through a Line Impedance Stabilization Network (LISN), which supplied power source and was grounded to the ground plane.

All support equipment power received from a second LISN.

The EUT test program was started. Emissions were measured on each current carrying line of the EUT using an EMI Test Receiver connected to the LISN powering the EUT.

The Receiver scanned from 150kHz to 30MHz for emissions in each of the test modes.

During the above scans, the emissions were maximized by cable manipulation.

The test mode(s) described in Item 4.1 were scanned during the preliminary test.

After the preliminary scan, we found the test mode described in Item 4.1 producing the highest emission level.

The EUT configuration and cable configuration of the above highest emission levels were recorded for reference of the final test.

#### **Procedure of Final Test**

EUT and support equipment were set up on the test bench as per the configuration with highest emission level in the preliminary test.

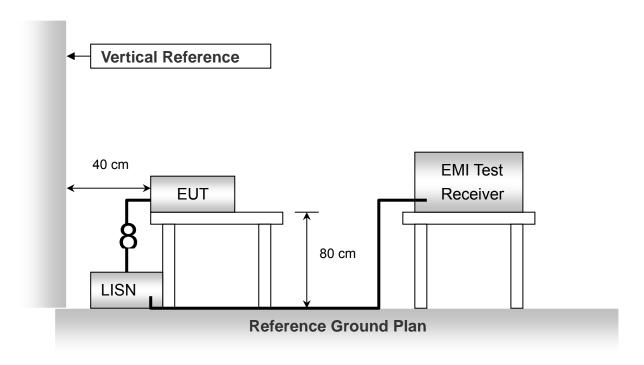
A scan was taken on both power lines, Line 1 and Line 2, recording at least the six highest emissions. Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit.

The test data of the worst-case condition(s) was recorded.



Page 13 of 77 Rev.00

# **7.1.4. TEST SETUP**



For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.

# 7.1.5. DATA SAMPLE

Freq. (MHz)	LISN Factor (dB)	Cable Loss (dB)	Meter Reading (dBuV)	Measured Level (dBuV)	Limits (dBuV)	Over Limits (dBuV)	Detector
X.XX	9.6	0.1	15.7	25.4	46	-20.6	QP

Freq. = Emission frequency in MHz

LISN Factor = Insertion loss of LISN and Pulse Limiter

Cable Loss = Insertion loss of Cable (LISN to EMI Tester Receiver)

Meter Reading = Uncorrected Analyzer/Receiver reading

Measured Level = Read Level + Factor Limit = Limit stated in standard Over Limit = Reading in reference to limit

Peak = Peak Reading
QP = Quasi-peak Reading
AV = Average Reading

# **Calculation Formula**

- 1. Measured Level (dBuV) = LISN Factor (dB) + Cable Loss (dB)+ Meter Reading (dBuV)
- 2. Over Limit (dBuV) = Measured Level (dBuV) Limits (dBuV)



Page 14 of 77 Rev.00

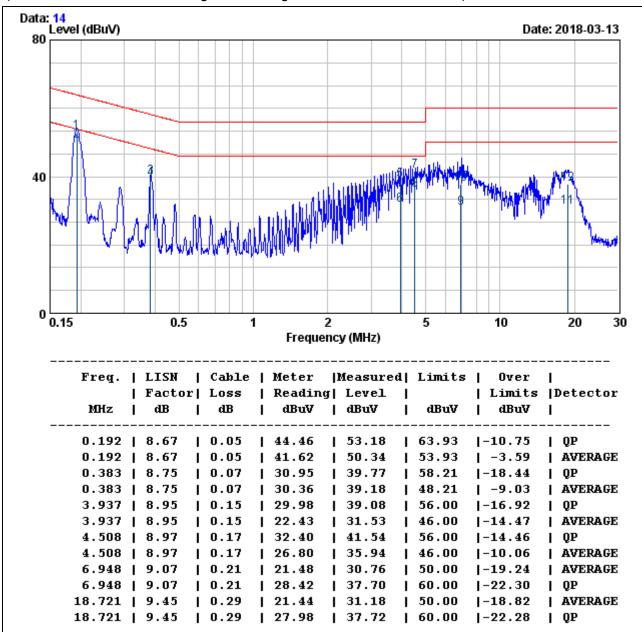
# 7.1.6. TEST RESULTS

Test Voltage: AC 110V, 60Hz

Model No.	500 BR	Test Mode	Full Load
Environmental Conditions	1977 61% DD	Resolution Bandwidth	9 kHz
Tested by	Weici Lo		

#### Line

(The chart below shows the highest readings taken from the final data.)



- 1. Measured Level (dBuV) = LISN Factor (dB) + Cable Loss (dB)+ Meter Reading (dBuV)
- 2. Over Limit (dBuV) = Measured Level (dBuV) Limits (dBuV)

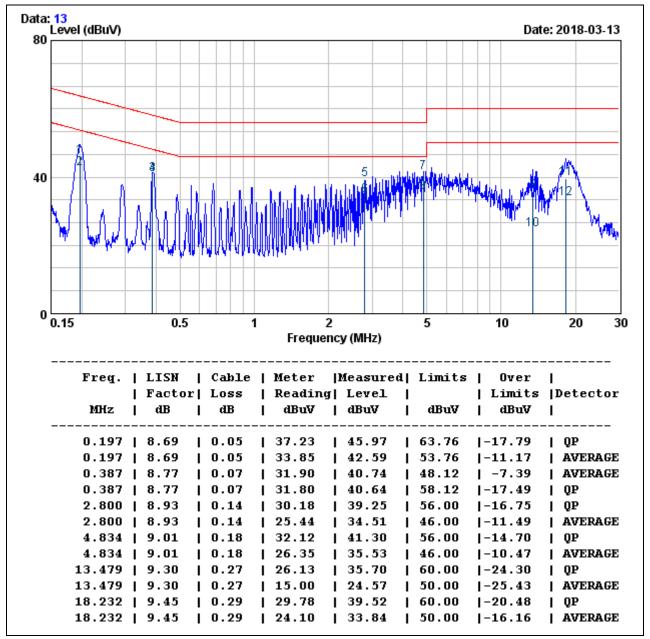


Page 15 of 77 Rev.00

Model No.	500 BR	Test Mode	Full Load
Environmental Conditions	197% 61% DU	Resolution Bandwidth	9 kHz
Tested by	Weici Lo		

#### Neutral

(The chart below shows the highest readings taken from the final data.)



- 1. Measured Level (dBuV) = LISN Factor (dB) + Cable Loss (dB)+ Meter Reading (dBuV)
- 2. Over Limit (dBuV) = Measured Level (dBuV) Limits (dBuV)



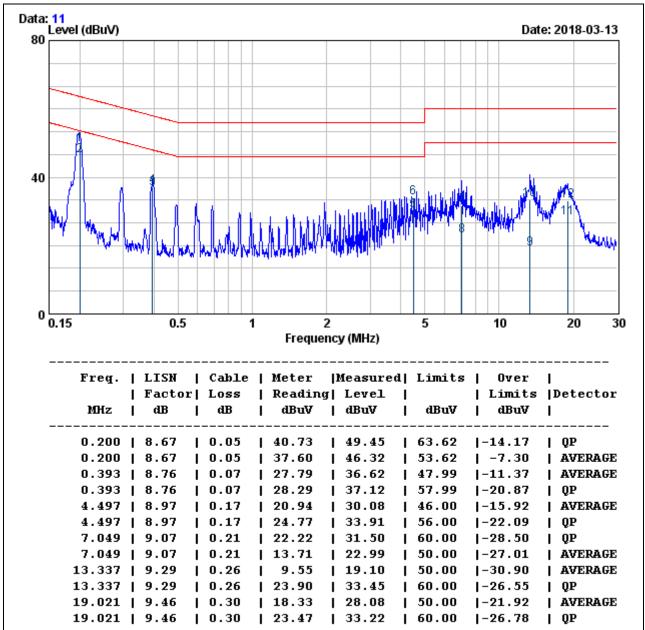
Page 16 of 77 Rev.00

Test Voltage: AC 230V, 50Hz

Model No.	500 BR	Test Mode	Full Load
Environmental Conditions	197% 61% DH	Resolution Bandwidth	9 kHz
Tested by	Weici Lo		

#### Line

(The chart below shows the highest readings taken from the final data.)



- 1. Measured Level (dBuV) = LISN Factor (dB) + Cable Loss (dB)+ Meter Reading (dBuV)
- 2. Over Limit (dBuV) = Measured Level (dBuV) Limits (dBuV)

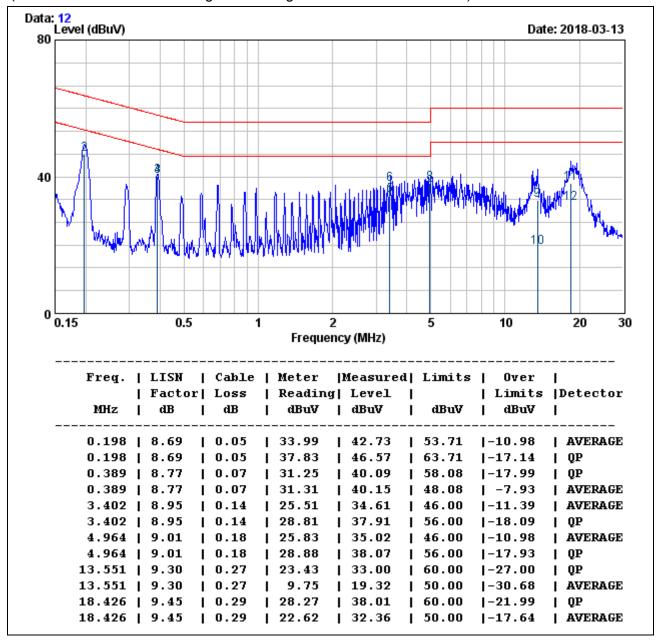


Page 17 of 77 Rev.00

Model No.	500 BR	Test Mode	Full Load
Environmental Conditions	127° 61% DH	Resolution Bandwidth	9 kHz
Tested by	Weici Lo		

#### **Neutral**

(The chart below shows the highest readings taken from the final data.)



- 1. Measured Level (dBuV) = LISN Factor (dB) + Cable Loss (dB)+ Meter Reading (dBuV)
- 2. Over Limit (dBuV) = Measured Level (dBuV) Limits (dBuV)



Page 18 of 77 Rev.00

# 7.2. CONDUCTED EMISSION MEASUREMENT AT ANALOGUE/DIGITAL DATA PORTS

# 7.2.1. **LIMITS**

For Class A Equipment

EDECLIENCY (MILE)	Voltage L	imit (dBuV)	Current Limit (dBuA)	
FREQUENCY (MHz)	Quasi-peak	Average	Quasi-peak	Average
0.15 ~ 0.5	97 ~ 87	84 ~ 74	53 ~ 43	40 ~ 30
0.5 ~ 30.0	87	74	43	30

**Note:** The limits decrease linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5 MHz. For Class B Equipment

EDECLIENCY (MH-)	Voltage L	imit (dBuV)	Current Limit (dBuA)		
FREQUENCY (MHz)	Quasi-peak	Average	Quasi-peak	Average	
0.15 - 0.5	84 ~ 74	74 ~ 64	40 ~ 30	30 ~ 20	
0.5 - 30.0	74	64	30	20	

**Note:** The limits decrease linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5 MHz.

# 7.2.2. TEST INSTRUMENTS

	Conducted Emission room # 1							
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due				
BNC Coaxial Cable	ccs	BNC50	11	01/23/2019				
EMI Test Receiver	R&S	ESCS 30	100348	01/30/2019				
FOUR BALACED PAIR ISN	FCC	F-071115-1057-1-0 9	111130	11/28/2018				
LISN	SCHWARZBECK	NNLK8130	8130124	11/30/2018				
LISN	FCC	FCC-LISN-50-32-2	08009	05/07/2018				
Pulse Limiter	R&S	ESH3-Z2	100116	01/23/2019				
Software	e-3 (5.04211j)							

#### Note:

- 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
- 2. N.C.R = No Calibration Request.



Page 19 of 77 Rev.00

#### 7.2.3. TEST PROCEDURE

Selecting ISN for unscreened cable or a current probe for screened cable to take measurement.

The port of the EUT was connected to the remote side support equipment through the ISN/Current Probe and communication in normal condition.

Making a overall range scan by using the test receiver controlled by controller and record at least six highest emissions for showing in the test report.

Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit.

In case of measuring on the screened cable, the current limit shall be applied; otherwise the voltage limit should be applied.

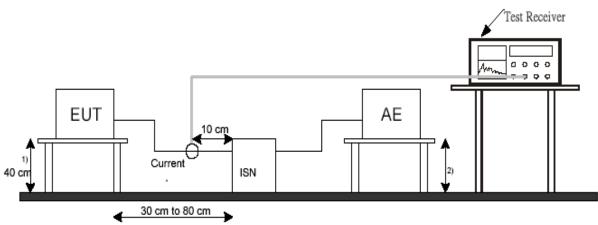
The following test modes was scanned during the preliminary test:

#### N/A

After the preliminary scan, we found the following test mode(s) producing the highest emission level and test data of the worst case was recorded.

N/A

# 7.2.4. TEST SETUP



- 1) Distance to the ground reference plane (vertical or horizontal).
- 2) Distance to the ground reference plane is not critical.

For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.



Page 20 of 77 Rev.00

#### 7.2.5. **DATA SAMPLE**

Freq. (MHz)	LISN Factor (dB)	Cable Loss (dB)	Meter Reading ()dBuV	Measured Level (dBuV)	Limits (dBuV)	Over Limits (dBuV)	Detector
X.XX	9.71	0.02	37.17	46.9	66	-19.10	QP

Freq. = Emission frequency in MHz

LISN Factor = Insertion loss of ISN and Pulse Limiter

= Insertion loss of of Cable (ISN to EMI Tester Receiver) Cable loss

Meter Reading = Uncorrected Analyzer/Receiver reading

Measured Level = Read Level + Factor = Limit stated in standard Limit = Reading in reference to limit Over Limit

= Peak Reading Peak QΡ

= Quasi-peak Reading ΑV = Average Reading

# **Calculation Formula**

Over Limit (dB) = Level (dBuV) – Limit (dBuV)

#### 7.2.6. **TEST RESULTS**

**%**Note: Not applicable, the EUT doesn't have LAN Port or Modem port.



Page 21 of 77 Rev.00

# 7.3. RADIATED EMISSION MEASUREMENT

# 7.3.1. LIMITS

# **Below 1GHz**

EDEOLIENCY (MILL-)	dBuV/m (At 10m)		
FREQUENCY (MHz)	Class A	Class B	
30 ~ 230	40	30	
230 ~ 1000	47	37	

**Note**: The lower limit shall apply at the transition frequencies.

# **Above 1GHz**

EDECLIENCY (MH-)	Class A (dBu	ıV/m) (At 3m)	Class B (dBuV/m) (At 3m)	
FREQUENCY (MHz)	Average	Peak	Average	Peak
1000 ~ 3000	56	76	50	70
3000 ~ 6000	60	80	54	74

**Note**: The lower limit shall apply at the transition frequencies.

According to EN 55032, the measurement frequency range shown in the following table:

Highest frequency generated or used within the EUT or on which the EUT operates or tunes (MHz)	Upper frequency of measurement range (MHz)
Less than 108	1000
108-500	2000
500-1000	5000
Above 1000	5 times of the highest frequency or 6GHz, whichever is less



Page 22 of 77 Rev.00

# 7.3.2. TEST INSTRUMENTS

# Open Area Test Site # 5

Open Area Test Site # 5					
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due	
Bi-Log Antenna	Sunol	JB1	A070506-1	03/19/2019	
EMI Test Receiver	R&S	ESCI 7	100856	11/16/2018	
Loop Antenna	COM-POWER	AL-130	121060	05/23/2018	
Type N coxical cable	Suhner	RG_214_U/2X	5	01/30/2019	
Software	e3 (5.04211j)				

# Open Area Test Site # 7

Open Area Test Site # 7							
Name of Equipment	Manufacturer	Manufacturer Model Serial Number Calibration Due					
Bi-Log Antenna	Sunol	JB1	A021306	03/19/2019			
EMI Test Receiver	R&S	ESCI	101336	04/16/2018			
Type N coxical cable	Suhner	RG_214_U/2X	7	01/29/2019			
Software	e3 (5.04211j)						

# ☐ Chamber room 966

Above 1GHz Used					
EXA Spectrum Analyzer	KEYSIGHT	N9010A	MY54430216	05/08/2018	
Horn Antenna	Com-Power	AH-118	071032	02/08/2019	
Pre-Amplifier	EMCI	EMC012645	980098	01/21/2019	

#### Note:

- 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
- 2. N.C.R. = No Calibration Request.



Page 23 of 77 Rev.00

#### 7.3.3. TEST PROCEDURE

#### **Procedure of Preliminary Test**

The equipment was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden turntable with a height of 0.8 meters is used which is placed on the ground plane. When the EUT is a floor standing equipment, it is placed on the ground plane which has a 15 cm non-conductive covering to insulate the EUT from the ground plane.

Support equipment, if needed, was placed as per EN 55032.

All I/O cables were positioned to simulate typical usage as per EN 55032.

The EUT received power source from the outlet socket under the turntable. All support equipment power received from another socket under the turntable.

The antenna was placed at 10/3 meter away from the EUT as stated in EN 55032. The antenna connected to the Spectrum Analyzer via a cable and at times a pre-amplifier would be used.

The Analyzer / Receiver quickly scanned from 30MHz to 6000MHz. The EUT test program was started. Emissions were scanned and measured rotating the EUT to 360 degrees and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.

The test mode(s) described in Item 4.1 were scanned during the preliminary test:

After the preliminary scan, we found the test mode described in Item 4.1 producing the highest emission level.

The EUT and cable configuration, antenna position, polarization and turntable position of the above highest emission level were recorded for the final test.

#### **Procedure of Final Test**

EUT and support equipment were set up on the turntable as per the configuration with highest emission level in the preliminary test.

The Analyzer / Receiver scanned from 30MHz to 6000MHz. Emissions were scanned and measured rotating the EUT to 360 degrees, varying cable placement and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.

Recorded at least the six highest emissions. Emission frequency, amplitude, antenna position, polarization and turntable position were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit and only Q.P. reading is presented.

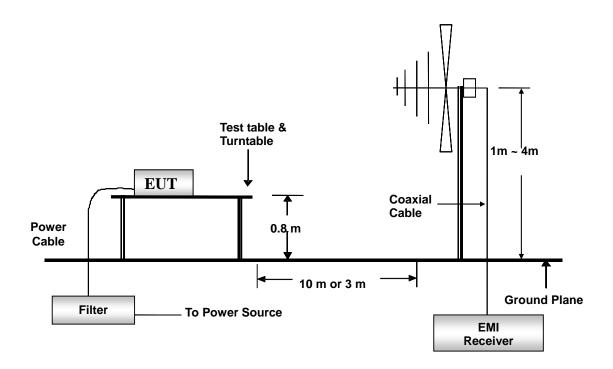
The test data of the worst-case condition(s) was recorded.



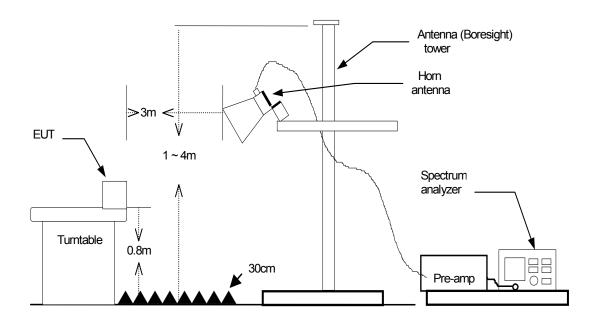
Page 24 of 77 Rev.00

# **7.3.4. TEST SETUP**

# **Below 1 GHz**



# **Above 1 GHz**



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



Page 25 of 77 Rev.00

# 7.3.5. DATA SAMPLE

Freq. (MHz)	Reading (dBuV/m)	Antenna Factor (dB)	Cable loss (dB)	Measure level (dBuV/m)	Limit (dBu/m)	Over limit (dBuV/m)	Detector
X.XX	24.48	7.33	1.50	33.31	40	-6.69	QP

Freq. = Emission frequency in MHz

Reading = Uncorrected Analyzer/Receiver reading

Antenna Factor = Antenna Factor

Cable loss = Insertion loss of cable
Measure level = Reading + Factor
Limit = Limit stated in standard
Over limit = Measure level – Limit

Peak = Peak Reading
QP = Quasi-peak Reading
AV = Average Reading

# **Calculation Formula**

Over limit (dBuV/m) = Result (dBuV/m) - Limit (dBuV/m)

#### **Above 1GHz**

Freq.	Reading	AF	C loss	Pre-amp	Filter	Level	Limit	Margin	Mark
(MHz)	(dBµV)	(dBµV)	(dB)	(dB)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	(P/Q/A)
XXXX. XX	56.00	25.14	2.07	41.77	0.72	42.16	70.00	-27.84	Р

Freq. = Emission frequency in MHz

Reading = Uncorrected Analyzer/Receiver reading

AF = Antenna Factor

C loss = Insertion loss of cable Pre-amp = Pre-amplifier Gain Filter = Insertion loss of filter

Level = Reading+AF+C loss-Pre-amp+Filter

Limit = Limit stated in standard

Margin = Reading in reference to limit

Mark: P = Peak Reading

Q = Quasi-peak ReadingA = Average Reading

# **Calculation Formula**

Margin (dB) =Level (dBuV/m) – Limit (dBuV/m)



Page 26 of 77 Rev.00

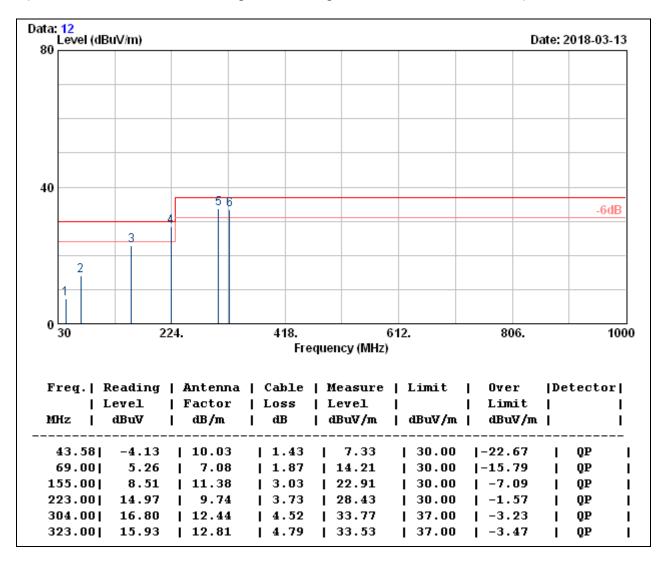
# 7.3.6. TEST RESULTS

#### **Below 1GHz**

Test Voltage: AC 110V, 60Hz

Model No.	500 BR	Test Mode	Full Load
Environmental Conditions	17/14 3/% DD	Resolution Bandwidth	120 kHz
Antenna Pole	Vertical	Antenna Distance	10m
Detector Function	Quasi-peak.	Tested by	Event Cheng

(The chart below shows the highest readings taken from the final data.)



Note: 1. QP= Quasi-peak Reading.

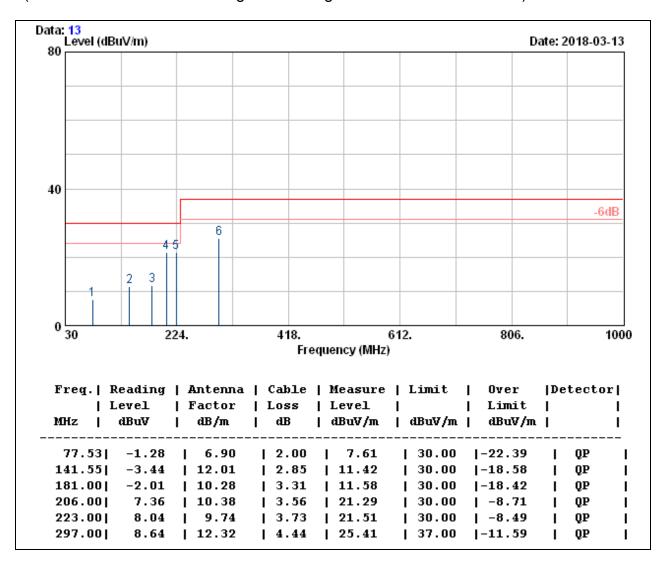
2. The other emission levels were very low against the limit



Page 27 of 77 Rev.00

Model No.	500 BR	Test Mode	Full Load
Environmental Conditions	1914 37% DD	Resolution Bandwidth	120 kHz
Antenna Pole	Horizontal	Antenna Distance	10m
<b>Detector Function</b>	Quasi-peak.	Tested by	Event Cheng

(The chart below shows the highest readings taken from the final data.)



Note: 1. QP= Quasi-peak Reading.

2. The other emission levels were very low against the limit

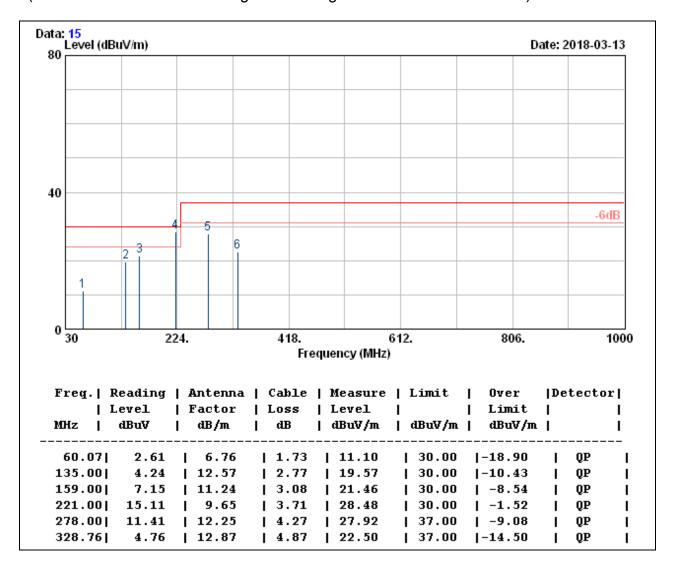


Page 28 of 77 Rev.00

Test Voltage: AC 230V, 50Hz

Model No.	500 BR	Test Mode	Full Load
Environmental Conditions	17/11 3/% DH	Resolution Bandwidth	120 kHz
Antenna Pole	Vertical	Antenna Distance	10m
Detector Function	Quasi-peak.	Tested by	Event Cheng

(The chart below shows the highest readings taken from the final data.)



Note: 1. QP= Quasi-peak Reading.

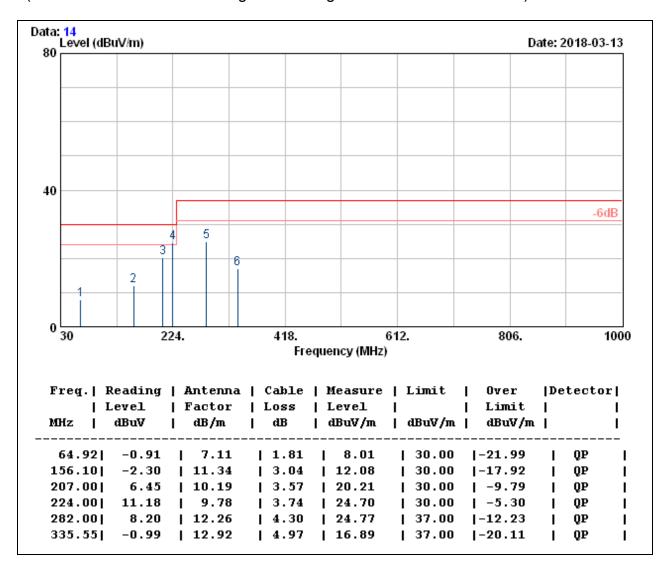
2. The other emission levels were very low against the limit



Page 29 of 77 Rev.00

Model No.	500 BR	Test Mode	Full Load
Environmental Conditions	1914 37% DD	Resolution Bandwidth	120 kHz
Antenna Pole	Horizontal	Antenna Distance	10m
<b>Detector Function</b>	Quasi-peak.	Tested by	Event Cheng

(The chart below shows the highest readings taken from the final data.)



Note: 1. QP= Quasi-peak Reading.

2. The other emission levels were very low against the limit

#### **Above 1GHz**

Not applicable, since the highest frequency of the internal sources of the EUT is less than 108MHz, the measurement shall only be made up to 1 GHz.



Page 30 of 77 Rev.00

# 7.4. HARMONICS CURRENT MEASUREMENT

# 7.4.1. LIMITS OF HARMONICS CURRENT MEASUREMENT

Limits for	Class A equipment
Harmonics Order n	Max. permissible harmonics current A
Od	ld harmonics
3	2.30
5	1.14
7	0.77
9	0.40
11	0.33
13	0.21
15<=n<=39	0.15x15/n
Eve	en harmonics
2	1.08
4	0.43
6	0.30
8<=n<=40	0.23x8/n

	Limits for Class D equipment				
Harmonics Order n	Max. permissible harmonics current per watt mA/W	Max. permissible harmonics current A			
	Odd Harmonics only				
3	3.4	2.30			
5	1.9	1.14			
7	1.0	0.77			
9	0.5	0.40			
11	0.35	0.33			
13	0.30	0.21			
15<=n<=39	3.85/n	0.15x15/n			

#### Note:

- 1. Class A and Class D are classified according to item 7.4.3.
- 2. According to section 7 of EN 61000-3-2, the above limits for all equipment except for lighting equipment having an active input power > 75 W and no limits apply for equipment with an active input power up to and including 75 W.

# 7.4.2. TEST INSTRUMENTS

Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due	
		Profline		03/02/2019	
Harmonic & Flicker	Teseq	2105(NSG	1504402655		
Test System		1007/CCN	1504A02655		
		1000-1)			
Software		Win2100v4 Version 4.5.8			

**Note:** The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.



Page 31 of 77 Rev.00

### 7.4.3. TEST PROCEDURE

The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.

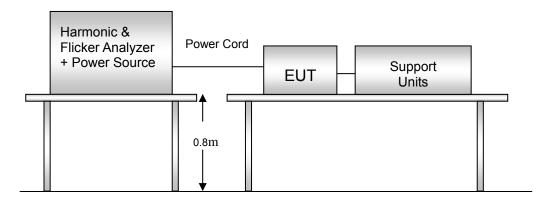
The classification of EUT is according to section 5 of EN 61000-3-2.

The EUT is classified as follows:

- Class A: Balanced three-phase equipment, Household appliances excluding equipment as Class D, Tools excluding portable tools, Dimmers for incandescent lamps, audio equipment, equipment not specified in one of the three other classes.
- Class B: Portable tools; Arc welding equipment which is not professional equipment.
- Class C: Lighting equipment.
- Class D: Equipment having a specified power less than or equal to 600 W of the following types: Personal computers and personal computer monitors and television receivers.

The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.

#### 7.4.4. TEST SETUP



For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.



Page 32 of 77 Rev.00

#### 7.4.5. TEST RESULTS

For Model: 500 BR

Power Consumption	508.7W / 508.1W	Test Mode	Normal Operation
Environmental Conditions	24°ℂ, 48% RH, 1028 mbar	Tested by	Taiyu Cyu

#### Note:

1. Limits classified according to item 7.4.3.

2. According to clause 7 of EN 61000-3-2, equipment with a rated power of 75W or less, no limits apply. The test result is only for reference.

# Test result of EN 61000-3-2

Harmonics - Class-A per Ed. 4.0 (2014)(Run time)

EUT: Equipment under test Tested by: Taiyu.Cyu

Test category: Class-A per Ed. 4.0 (2014) (European limits) Test Margin: 100

Test date: 2018/3/16 Start time: AM 11:14:04 End time: AM 11:24:15

Test duration (min): 10 Data file name: H-000392.cts\_data

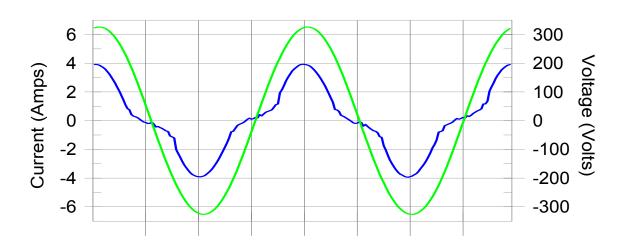
**Customer: EVGA Corporation** 

**Equipment Under Test:Switching Power Supply** 

Model:500 BR

Test Result: Pass Source qualification: Normal

# **Current & voltage waveforms**

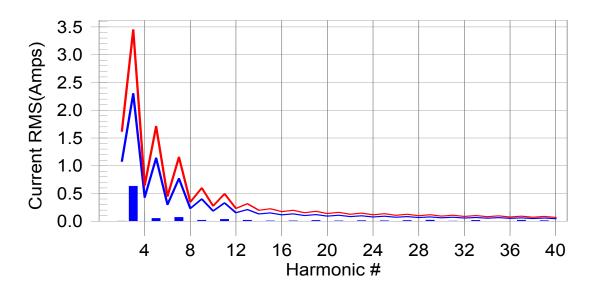


**Harmonics and Class A limit line** 

**European Limits** 



Page 33 of 77 Rev.00



Test result: Pass Worst harmonics H37-22.6% of 150% limit, H37-32.7% of 100% limit



Page 34 of 77 Rev.00

# **Current Test Result Summary (Run time)**

EUT: Equipment under test Tested by: Taiyu.Cyu

Test category: Class-A per Ed. 4.0 (2014) (European limits) Test Margin: 100

Test date: 2018/3/16 Start time: AM 11:14:04 End time: AM 11:24:15

Test duration (min): 10 Data file name: H-000392.cts\_data

**Customer: EVGA Corporation** 

**Equipment Under Test:Switching Power Supply** 

Model:500 BR

Test Result: Pass Source qualification: Normal

THC(A): 0.642 I-THD(%): 28.9 POHC(A): 0.043 POHC Limit(A): 0.251

Highest parameter values during test:

 V\_RMS (Volts):
 230.90
 Frequency(Hz):
 50.00

 I\_Peak (Amps):
 3.969
 I\_RMS (Amps):
 2.316

 I\_Fund (Amps):
 2.220
 Crest Factor:
 1.719

 Power (Watts):
 508.7
 Power Factor:
 0.953

Harm#	Harms(avg)	100%Limit	%of Limit	Harms(max)	150%Limit	%of Limit	Status
2	0.002	1.080	N/A	0.002	1.620	N/A	Pass
3	0.632	2.300	27.5	0.638	3.450	18.5	Pass
4	0.001	0.430	N/A	0.001	0.645	N/A	Pass
5	0.051	1.140	4.5	0.052	1.710	3.0	Pass
6	0.001	0.300	N/A	0.001	0.450	N/A	Pass
7	0.071	0.770	9.2	0.072	1.155	6.3	Pass
8	0.000	0.230	N/A	0.001	0.345	N/A	Pass
9	0.020	0.400	5.1	0.021	0.600	3.6	Pass
10	0.000	0.184	N/A	0.000	0.276	N/A	Pass
11	0.034	0.330	10.2	0.035	0.495	7.0	Pass
12	0.000	0.153	N/A	0.001	0.230	N/A	Pass
13	0.019	0.210	9.2	0.020	0.315	6.3	Pass
14	0.000	0.131	N/A	0.000	0.197	N/A	Pass
15	0.007	0.150	N/A	0.007	0.225	N/A	Pass
16	0.000	0.115	N/A	0.000	0.173	N/A	Pass
17	0.009	0.132	N/A	0.010	0.198	N/A	Pass
18	0.000	0.102	N/A	0.001	0.153	N/A	Pass
19	0.015	0.118	12.7	0.015	0.178	8.7	Pass



Page 35 of 77 Rev.00

20	0.001	0.092	N/A	0.001	0.138	N/A	Pass
21	0.007	0.107	N/A	800.0	0.161	N/A	Pass
22	0.000	0.084	N/A	0.001	0.125	N/A	Pass
23	0.012	0.098	N/A	0.013	0.147	N/A	Pass
24	0.000	0.077	N/A	0.000	0.115	N/A	Pass
25	0.011	0.090	N/A	0.011	0.135	N/A	Pass
26	0.000	0.071	N/A	0.001	0.107	N/A	Pass
27	0.014	0.083	16.8	0.015	0.125	11.9	Pass
28	0.001	0.066	N/A	0.001	0.099	N/A	Pass
29	0.021	0.078	27.4	0.022	0.116	18.8	Pass
30	0.000	0.061	N/A	0.001	0.092	N/A	Pass
31	0.003	0.073	N/A	0.004	0.109	N/A	Pass
32	0.001	0.058	N/A	0.001	0.086	N/A	Pass
33	0.017	0.068	24.5	0.017	0.102	16.9	Pass
34	0.000	0.054	N/A	0.001	0.081	N/A	Pass
35	0.001	0.064	N/A	0.001	0.096	N/A	Pass
36	0.000	0.051	N/A	0.000	0.077	N/A	Pass
37	0.020	0.061	32.7	0.021	0.091	22.6	Pass
38	0.000	0.048	N/A	0.001	0.073	N/A	Pass
39	0.013	0.058	N/A	0.014	0.087	N/A	Pass
40	0.001	0.046	N/A	0.001	0.069	N/A	Pass



Rev.00

Page 36 of 77

# **Voltage Source Verification Data (Run time)**

EUT: Equipment under test Tested by: Taiyu.Cyu

Test category: Class-A per Ed. 4.0 (2014) (European limits) Test Margin: 100

Test date: 2018/3/16 Start time: AM 11:14:04 End time: AM 11:24:15

Test duration (min): 10 Data file name: H-000392.cts\_data

**Customer: EVGA Corporation** 

**Equipment Under Test:Switching Power Supply** 

Model:500 BR

Test Result: Pass Source qualification: Normal

## Highest parameter values during test:

 Voltage (Vrms):
 230.90
 Frequency(Hz):
 50.00

 I\_Peak (Amps):
 3.969
 I\_RMS (Amps):
 2.316

 I\_Fund (Amps):
 2.220
 Crest Factor:
 1.719

 Power (Watts):
 508.7
 Power Factor:
 0.953

Harm#	Harmonics V-rms	Limit V-rms	% of Limit	Status
2	0.026	0.462	7.04	OK
2	0.036	0.462	7.84	OK
3	0.500	2.078	24.07	OK
4	0.018	0.462	3.92	OK
5	0.032	0.923	3.47	ОК
6	0.013	0.462	2.77	ОК
7	0.054	0.693	7.73	ОК
8	0.012	0.462	2.58	ОК
9	0.011	0.462	2.41	ОК
10	0.011	0.462	2.30	ОК
11	0.014	0.231	5.99	ОК
12	0.015	0.231	6.36	ОК
13	0.011	0.231	4.78	ОК
14	0.006	0.231	2.52	ОК
15	0.010	0.231	4.40	ОК
16	0.009	0.231	3.93	ОК
17	0.013	0.231	5.43	ОК
18	0.007	0.231	3.11	ок
19	0.014	0.231	5.85	ок
20	0.029	0.231	12.41	ОК



Report No.: T180226N02-E
Page 37 of 77 Rev.00

21	0.014	0.231	5.89	ок
22	0.008	0.231	3.50	ок
23	0.012	0.231	5.22	ок
24	0.003	0.231	1.49	ок
25	0.014	0.231	5.96	ок
26	0.003	0.231	1.36	ок
27	0.011	0.231	4.83	ок
28	0.003	0.231	1.36	ок
29	0.023	0.231	9.78	ок
30	0.003	0.231	1.27	ок
31	0.003	0.231	1.33	ок
32	0.002	0.231	1.02	ок
33	0.024	0.231	10.59	ок
34	0.003	0.231	1.12	ок
35	0.003	0.231	1.27	ок
36	0.003	0.231	1.22	ок
37	0.029	0.231	12.63	ок
38	0.003	0.231	1.10	ок
39	0.024	0.231	10.41	ок
40	0.016	0.231	7.08	ок



Page 38 of 77 Rev.00

# Harmonics – Class-D per Ed. 4.0 (2014)(Run time)

EUT: Equipment under test Tested by: Taiyu.Cyu

Test category: Class-D per Ed. 4.0 (2014) (European limits) Test Margin: 100

Test date: 2018/3/16 Start time: AM 11:25:05 End time: AM 11:35:16

Test duration (min): 10 Data file name: H-000393.cts\_data

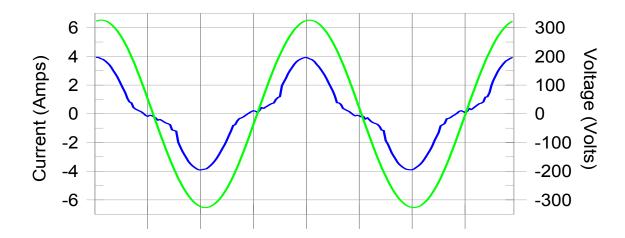
**Customer: EVGA Corporation** 

**Equipment Under Test:Switching Power Supply** 

Model:500 BR

Test Result: Pass Source qualification: Normal

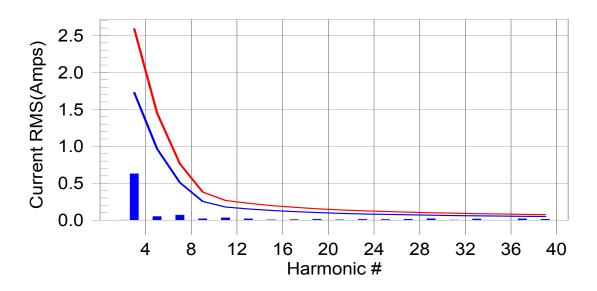
**Current & voltage waveforms** 



Harmonics and Class D limit line European Limits



Page 39 of 77 Rev.00



Test result: Pass Worst harmonics H37-24.8% of 150% limit, H37-36.7% of 100% limit



Page 40 of 77 Rev.00

# **Current Test Result Summary (Run time)**

EUT: Equipment under test Tested by: Taiyu.Cyu

Test category: Class-D per Ed. 4.0 (2014) (European limits) Test Margin: 100

Test date: 2018/3/16 Start time: AM 11:25:05 End time: AM 11:35:16

Test duration (min): 10 Data file name: H-000393.cts\_data

**Customer: EVGA Corporation** 

**Equipment Under Test:Switching Power Supply** 

Model:500 BR

Test Result: Pass Source qualification: Normal

THC(A): 0.638 I-THD(%): 28.8 POHC(A): 0.042 POHC Limit(A): 0.218

Highest parameter values during test:

 V\_RMS (Volts):
 230.93
 Frequency(Hz):
 50.00

 I\_Peak (Amps):
 3.959
 I\_RMS (Amps):
 2.309

 I\_Fund (Amps):
 2.217
 Crest Factor:
 1.720

 Power (Watts):
 508.1
 Power Factor:
 0.954

Harm#	Harms(avg)	100%Limit	%of Limit	Harms(max)	150%Limit	%of Limit	Status
2	0.002	0.000	N/A	0.002	0.000	N/A	Pass
3	0.629	1.728	36.4	0.630	2.591	24.3	Pass
4	0.001	0.000	N/A	0.001	0.000	N/A	Pass
5	0.051	0.965	5.2	0.052	1.448	3.6	Pass
6	0.001	0.000	N/A	0.001	0.000	N/A	Pass
7	0.069	0.508	13.7	0.070	0.762	9.1	Pass
8	0.000	0.000	N/A	0.001	0.000	N/A	Pass
9	0.020	0.254	7.9	0.020	0.381	5.3	Pass
10	0.000	0.000	N/A	0.000	0.000	N/A	Pass
11	0.033	0.178	18.5	0.033	0.267	12.4	Pass
12	0.000	0.000	N/A	0.001	0.000	N/A	Pass
13	0.019	0.152	12.4	0.019	0.229	8.3	Pass
14	0.000	0.000	N/A	0.000	0.000	N/A	Pass
15	0.006	0.132	N/A	0.006	0.198	N/A	Pass
16	0.000	0.000	N/A	0.000	0.000	N/A	Pass
17	0.009	0.117	N/A	0.009	0.175	N/A	Pass
18	0.000	0.000	N/A	0.001	0.000	N/A	Pass
19	0.015	0.103	14.5	0.015	0.155	9.8	Pass



Page 41 of 77 Rev.00

20	0.001	0.000	N/A	0.001	0.000	N/A	Pass
21	0.008	0.093	N/A	800.0	0.139	N/A	Pass
22	0.000	0.000	N/A	0.001	0.000	N/A	Pass
23	0.012	0.085	N/A	0.012	0.127	N/A	Pass
24	0.000	0.000	N/A	0.000	0.000	N/A	Pass
25	0.011	0.078	N/A	0.011	0.117	N/A	Pass
26	0.000	0.000	N/A	0.001	0.000	N/A	Pass
27	0.014	0.073	N/A	0.014	0.109	N/A	Pass
28	0.001	0.000	N/A	0.001	0.000	N/A	Pass
29	0.021	0.068	31.5	0.022	0.101	21.7	Pass
30	0.000	0.000	N/A	0.001	0.000	N/A	Pass
31	0.003	0.063	N/A	0.004	0.095	N/A	Pass
32	0.001	0.000	N/A	0.001	0.000	N/A	Pass
33	0.017	0.059	28.1	0.017	0.088	19.1	Pass
34	0.000	0.000	N/A	0.001	0.000	N/A	Pass
35	0.001	0.056	N/A	0.001	0.084	N/A	Pass
36	0.000	0.000	N/A	0.001	0.000	N/A	Pass
37	0.019	0.053	36.7	0.020	0.079	24.8	Pass
38	0.000	0.000	N/A	0.001	0.000	N/A	Pass
39	0.014	0.050	N/A	0.014	0.075	N/A	Pass
40	0.001	0.000	N/A	0.001	0.000	N/A	Pass

Note: Measured power limits were applied for this test. The rated power is 100.0 Watts.



Page 42 of 77 Rev.00

# **Voltage Source Verification Data (Run time)**

EUT: Equipment under test Tested by: Taiyu.Cyu

Test category: Class-D per Ed. 4.0 (2014) (European limits) Test Margin: 100

Test date: 2018/3/16 Start time: AM 11:25:05 End time: AM 11:35:16

Test duration (min): 10 Data file name: H-000393.cts\_data

**Customer: EVGA Corporation** 

**Equipment Under Test:Switching Power Supply** 

Model:500 BR

Test Result: Pass Source qualification: Normal

## Highest parameter values during test:

 Voltage (Vrms):
 230.93
 Frequency(Hz):
 50.00

 I\_Peak (Amps):
 3.959
 I\_RMS (Amps):
 2.309

 I\_Fund (Amps):
 2.217
 Crest Factor:
 1.720

 Power (Watts):
 508.1
 Power Factor:
 0.954

Harm#	Harmonics V-rms	Limit V-rms	% of Limit	Status
•	0.000	0.400	7.70	014
2	0.036	0.462	7.76	OK
3	0.502	2.078	24.15	OK
4	0.018	0.462	3.96	OK
5	0.031	0.924	3.39	ОК
6	0.012	0.462	2.59	OK
7	0.051	0.693	7.38	ОК
8	0.012	0.462	2.55	ОК
9	0.010	0.462	2.11	ОК
10	0.010	0.462	2.24	ок
11	0.013	0.231	5.73	ок
12	0.014	0.231	6.08	ОК
13	0.011	0.231	4.80	ОК
14	0.006	0.231	2.63	ОК
15	0.010	0.231	4.17	ОК
16	0.009	0.231	4.04	ОК
17	0.014	0.231	6.16	ОК
18	0.008	0.231	3.62	ок
19	0.014	0.231	5.92	ок
20	0.026	0.231	11.23	ок



Report No.: T180226N02-E
Page 43 of 77 Rev.00

21	0.011	0.231	4.94	ок
22	0.006	0.231	2.71	ок
23	0.012	0.231	4.99	ок
24	0.003	0.231	1.36	ок
25	0.013	0.231	5.75	ок
26	0.003	0.231	1.23	ок
27	0.011	0.231	4.65	ок
28	0.003	0.231	1.31	ок
29	0.022	0.231	9.71	ок
30	0.003	0.231	1.34	ок
31	0.003	0.231	1.26	ок
32	0.002	0.231	1.08	ок
33	0.024	0.231	10.41	ок
34	0.003	0.231	1.15	ок
35	0.002	0.231	1.08	ок
36	0.003	0.231	1.21	ок
37	0.028	0.231	12.11	ок
38	0.003	0.231	1.10	ок
39	0.023	0.231	10.12	ок
40	0.016	0.231	6.89	ок



Page 44 of 77 Rev.00

# 7.5. VOLTAGE FLUCTUATION AND FLICKER MEASUREMENT

## 7.5.1. LIMITS OF VOLTAGE FLUCTUATION AND FLICKER MEASUREMENT

TEST ITEM	LIMIT	REMARK
P <sub>st</sub>	1.0	P <sub>st</sub> means short-term flicker indicator.
P <sub>lt</sub>	0.65	P <sub>lt</sub> means long-term flicker indicator.
T <sub>dt</sub> (ms)	500	T <sub>dt</sub> means maximum time that dt exceeds 3 %.
d <sub>max</sub> (%)	4%	d <sub>max</sub> means maximum relative voltage change.
dc (%)	3.3%	dc means relative steady-state voltage change

#### 7.5.2. TEST INSTRUMENTS

	IMMUNITY SHIELDED ROOM					
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due		
Harmonic & Flicker Test System	Teseq	Profline 2105(NSG 1007/CCN 1000-1)	1504A02655	03/02/2019		
Software	Win2100v4 Version 4.5.8					

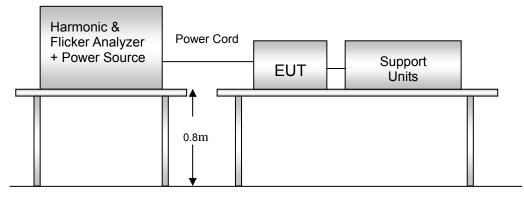
**Note:** The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

#### 7.5.3. TEST PROCEDURE

The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.

During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

#### 7.5.4. TEST SETUP



For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.



Page 45 of 77 Rev.00

## 7.5.5. TEST RESULTS

For Model: 500 BR

Observation Period (Tp)	120min	Test Mode	Normal Operation
Environmental Conditions	25℃, 48% RH, 1028mbar	Tested by	Taiyu Cyu

# Test result of EN 61000-3-3

# Flicker Test Summary per EN/IEC61000-3-3 Ed. 3.0 (2013) (Run time)

EUT: Equipment under test Tested by: Taiyu.Cyu

Test category: All parameters (European limits)

Test Margin: 100

Test date: 2018/3/16 Start time: AM 11:35:56 End time: AM 11:46:24

Test duration (min): 10 Data file name: F-000394.cts\_data

**Customer: EVGA Corporation** 

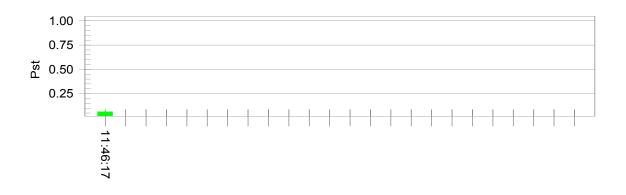
**Equipment Under Test:Switching Power Supply** 

Model:500 BR

Test Result: Pass Status: Test Completed

#### Pst<sub>i</sub> and limit line

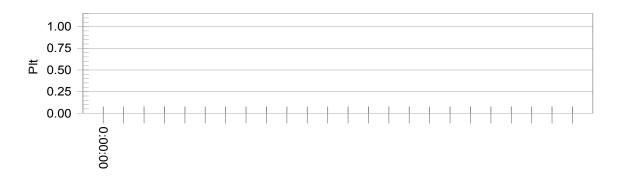
## European Limits



#### Plt and limit line



Page 46 of 77 Rev.00



# Parameter values recorded during the test:

<b>Vrms</b>	at the	end of	test	(Volt):	230.88

Highest dt (%):	0.00	Test limit (%):	N/A	N/A
T-max (mS):	0	Test limit (mS):	500.0	Pass
Highest dc (%):	0.00	Test limit (%):	3.30	Pass
Highest dmax (%):	0.00	Test limit (%):	4.00	Pass
Highest Pst (10 min. period):	0.064	Test limit:	1.000	Pass
Highest Plt (2 hr. period):	0.028	Test limit:	0.650	Pass



Page 47 of 77 Rev.00

# **8 IMMUNITY TEST**

# **8.1. GENERAL DESCRIPTION**

Dreduct Ctandard	EN 55024: 2010			
Product Standard	Test Type	Minimum Requirement		
	IEC 61000-4-2	Electrostatic Discharge - ESD: 8KV air discharge, 4kV Contact discharge, Performance Criterion B		
	IEC 61000-4-3	Radio-Frequency Electromagnetic Field Susceptibility Test - RS: 80 ~1000 MHz, 3V/m, 80% AM(1kHz), Performance Criterion A		
	IEC 61000-4-4	Electrical Fast Transient/Burst - EFT, AC Power Port: 1kV DC Power Port: 0.5kV Signal Ports and Telecommunication Ports: 0.5kV Performance Criterion B		
Basic Standard, Specification, and Performance Criterion required	IEC 61000-4-5	Surge Immunity Test: 1.2/50 us Open Circuit Voltage, 8/20 us Short Circuit Current, AC Power Port ~ line to line: 1kV,		
	IEC 61000-4-6	Conducted Radio Frequency Disturbances Test - CS: 0.15 ~ 80 MHz, 3Vrms, 80% AM, 1kHz, Performance Criterion A		
	IEC 61000-4-8	Power frequency magnetic field immunity test 50 Hz, 1A/m Performance Criterion A		
	IEC 61000-4-11	Voltage Dips:  i) >95% reduction for 0.5 periods, Performance Criterion B  ii) 30% reduction for 25 periods, Performance Criterion C  Voltage Interruptions: >95% reduction for 250 periods Performance Criterion C		



Page 48 of 77 Rev.00

# 8.2. GENERAL PERFORMANCE CRITERIA DESCRIPTION

Criteria A:	The apparatus shell continues to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. If the manufacturer does not specify the minimum performance level or the permissible performance loss, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
	After test, the apparatus shell continues to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomenon below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance.
Criteria B:	During the test, degradation of performance is however allowed. However, no change of operating state if stored data is allowed to persist after the test. If the manufacturer does not specify the minimum performance level or the permissible performance loss, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
Criteria C:	Temporary loss of function is allowed, provided the functions is self-recoverable or can be restored by the operation of controls by the user in accordance with the manufacturer instructions.
	Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.



Page 49 of 77 Rev.00

# 8.3. ELECTROSTATIC DISCHARGE (ESD)

#### 8.3.1. **TEST SPECIFICATION**

Basic Standard: IEC 61000-4-2

Discharge Impedance: 330 ohm / 150 pF

Discharge Voltage: Air Discharge: --- kV (Direct)
Contact Discharge: 4 kV (Direct/Indirect)

Polarity: Positive & Negative

Air Discharge: min. 10 times at each test point for each polarity Number of Discharge:

Contact Discharge: min. 200 times in total

Single Discharge **Discharge Mode:** 1 second minimum

#### **TEST INSTRUMENT** 8.3.2.

IMMUNITY SHIELDED ROOM								
Name of Equipment Manufacturer Model Serial Number Calibration D								
ESD Simulator	NoiseKen	TC-815R	ESS1366835	08/31/2018				
ESD Simulator	NoiseKen	ESS-2002	ESS04Z3762	08/31/2018				

Note: The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.



Page 50 of 77 Rev.00

## 8.3.3. TEST PROCEDURE

The discharges shall be applied in two ways:

- a) Contact discharges to the conductive surfaces and coupling planes:
  - The EUT shall be exposed to at least 200 discharges, 100 each at negative and positive polarity, at a minimum of four test points. One of the test points shall be subjected to at least 50 indirect discharges to the center of the front edge of the Horizontal Coupling Plane (HCP). The remaining three test points shall each receive at least 50 direct contact discharges. If no direct contact test points are available, then at least 200 indirect discharges shall be applied in the indirect mode. Test shall be performed at a maximum repetition rate of one discharge per second.
- b) Air discharges at slots and apertures and insulating surfaces:
  - On those parts of the EUT where it is not possible to perform contact discharge testing, the equipment should be investigated to identify user accessible points where breakdown may occur. Such points are tested using the air discharge method. This investigation should be restricted to those area normally handled by the user. A minimum of 10 single air discharges shall be applied to the selected test point for each such area.

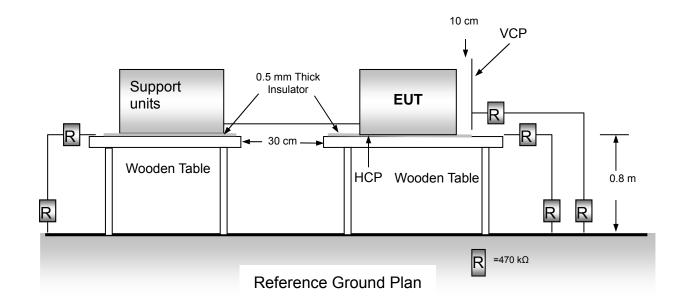
The basic test procedure was in accordance with IEC 61000-4-2:

- a) The EUT was located 0.1 m minimum from all side of the HCP (dimensions 1.6m x 0.8m).
- b) The support units were located another table 30 cm away from the EUT, but direct support unit was/were located at same location as EUT on the HCP and keep at a distance of 10 cm with EUT.
- c) The time interval between two successive single discharges was at least 1 second.
- d) Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- e) Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.
- f) At least ten single discharges (in the most sensitive polarity) were applied at the front edge of each HCP opposite the center point of each unit of the EUT and 0.1 meters from the front of the EUT. The long axis of the discharge electrode was in the plane of the HCP and perpendicular to its front edge during the discharge.
- g) At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the Vertical Coupling Plane (VCP) in sufficiently different positions that the four faces of the EUT were completely illuminated. The VCP (dimensions 0.5m x 0.5m) was placed vertically to and 0.1 meters from the EUT.



Page 51 of 77 Rev.00

#### 8.3.4. TEST SETUP



For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.

## Note:

#### **TABLETOP EQUIPMENT**

The configuration consisted of a wooden table 0.8 meters high standing on the **G**round **R**eference **P**lane. The **GRP** consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A **H**orizontal **C**oupling **P**lane (1.6m x 0.8m) was placed on the table and attached to the **GRP** by means of a cable with 940kohm total impedance. The equipment under test, was installed in a representative system as described in section 7 of IEC 61000-4-2, and its cables were placed on the **HCP** and isolated by an insulating support of 0.5mm thickness. A distance of 1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

#### FLOOR-STANDING EQUIPMENT

The equipment under test was installed in a representative system as described in section 7 of IEC 61000-4-2, and its cables were isolated from the Ground Reference Plane by an insulating support of 0.1-meter thickness. The GRP consisted of a sheet of aluminum that is at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system and extended at least 0.5 meters from the EUT on all sides.



Page 52 of 77 Rev.00

# 8.3.5. TEST RESULTS For Model: 500 BR

Temperature	24°C	Humidity	48% RH
Pressure	1028mbar	Tested By	Taiyu Cyu
Required Passing Performance	Criterion B	Test Mode	Full Load

Test Date: 2018/03/16

163t Date: 2010/00/10								
Air Discharge								
	Т	est Level	S			Results		
Test Points	± 2 kV	± 4 kV	± 8 kV	Pass Fail Performance Criterion				
Front						□A □B		
Back						□A □B		
Left						□A □B		
Right						□A □B		
Тор						<b>□</b> A <b>□</b> B		
Bottom						<b>□</b> A <b>□</b> B		

Contact Discharge								
	T	est Level	S			Results		
Test Points	± 2 kV	± 4 kV	± 8 kV	Pass	Performance			
Front						⊠A □B		
Back		$\boxtimes$				⊠A □B		
Left		$\boxtimes$		$\boxtimes$		⊠A □B		
Right		$\boxtimes$				⊠A □B		
Тор						⊠A □B		
Bottom						<b>□</b> A <b>□</b> B		

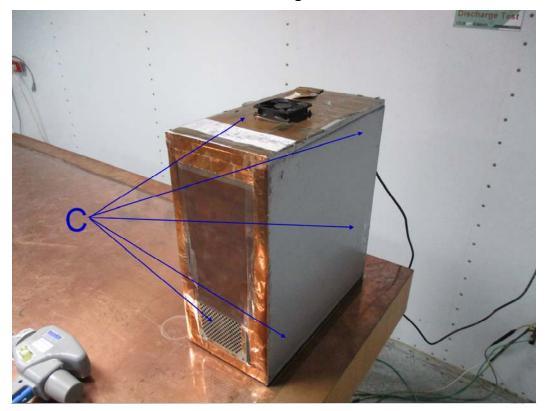
Discharge To Horizontal Coupling Plane								
	Test Levels Results							
Side of EUT	± 2 kV	±4 kV	±8 kV	Pass	Fail	Performance Criterion		
Front						⊠A □B		
Back					Ħ	⊠A □B		
Left						⊠A □B		
Right						⊠A □B		

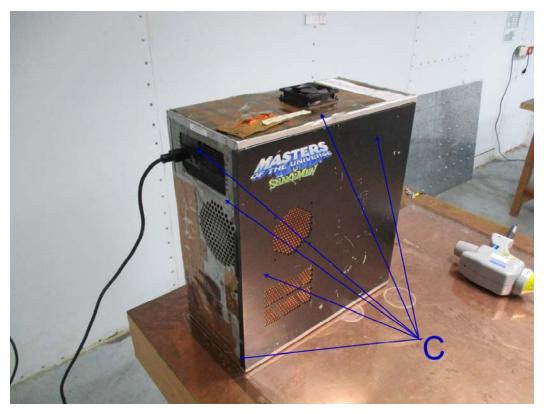
Discharge To Vertical Coupling Plane							
	T	Test Levels Results					
Side of EUT	± 2 kV	± 4 kV	± 8 kV	Pass	Fail	Performance Criterion	
Front				$\boxtimes$		$oxed{oxed}$ A $oxed{oxed}$ B	
Back						⊠A □B	
Left						⊠A □B	
Right				$\boxtimes$		⊠A □B	



Page 53 of 77 Rev.00

# The Photo for Discharge Points of EUT





'A' Mark — Air Discharged ; 'C' Mark — Contact Discharged



Page 54 of 77 Rev.00

# 8.4. RADIATED, RADIO-FREQUENCY, ELECTROMAGNETIC FIELD (RS)

## 8.4.1. TEST SPECIFICATION

Basic Standard: IEC 61000-4-3

Frequency Range: 80 MHz ~1000 MHz

Field Strength: 3 V/m

**Modulation:** 1kHz Sine Wave, 80%, AM Modulation

**Frequency Step:** 1 % of preceding frequency value

Polarity of Antenna: Horizontal and Vertical

Test Distance: 3 m

Antenna Height: 1.5m

## 8.4.2. TEST INSTRUMENT

966 RS Chamber								
Name of Equipment	Manufacturer	ufacturer Model		Calibration Due				
Power SENSOR	Boonton	51011-EMC	33428	05/07/2018				
Power SENSOR	Boonton	51011-EMC	33429	05/07/2018				
RS Power Meter	Boonton	4232A-01-02	122202	05/07/2018				
Signal Generator	hp	ESG-D3000A	US36260655	05/03/2018				
Amplifier	ar	50S1G6M1	0343693	N.C.R				
Amplifier	ar	150W1000M3	310037	N.C.R				
Amplifier	ar	250W1000BM1	0579763	N.C.R				
Software		RS SW10	05 R1_4					

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. N.C.R. = No Calibration required



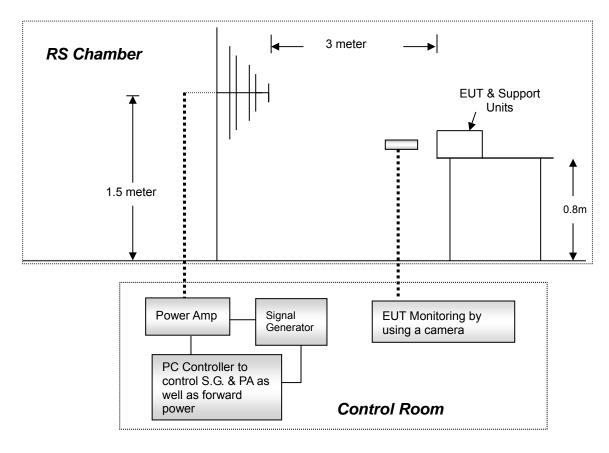
Page 55 of 77 Rev.00

#### 8.4.3. TEST PROCEDURE

The test procedure was in accordance with IEC 61000-4-3

- a) The testing was performed in a fully anechoic chamber. The transmit antenna was located at a distance of 3 meters from the EUT.
- b) The frequency range is swept from 80 MHz to 1000 MHz, with the signal 80% amplitude modulated with a 1kHz sine-wave. The rate of sweep did not exceed 1.5 x 10<sup>-3</sup> decade/s, where the frequency range is swept incrementally, the step size was 1% of preceding frequency value.
- c) The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- d) The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

#### 8.4.4. TEST SETUP



For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.

#### Note:

#### TABLETOP EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.



Page 56 of 77 Rev.00

## FLOOR-STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC 61000-4-3 was placed on a non-conductive wood support 0.1 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

## 8.4.5. TEST RESULTS

For Model: 500 BR

Temperature	25°C	Humidity	47% RH	
Pressure	1028mbar	Dwell Time	3 sec.	
Tested By	Taiyu Cyu	Test Mode	Full Load	
Required Passing Perfe	ormance	Criterion A		

Frequency (MHz)	Polarity	Azimuth	Field Strength (V/m)	Performance Criterion	Result	Observation
80 ~ 1000	V&H	0	3	⊠A □B	PASS	
80 ~ 1000	V&H	90	3	⊠A □B	PASS	
80 ~ 1000	V&H	180	3	⊠A □B	PASS	
80 ~ 1000	V&H	270	3	⊠A □B	PASS	



Page 57 of 77 Rev.00

# 8.5. ELECTRICAL FAST TRANSIENT (EFT)

## 8.5.1. TEST SPECIFICATION

Basic Standard: IEC 61000-4-4

**Test Voltage:** AC Power Port: 1 kV

DC Power Port: --- kV

Signal Ports and Telecommunication Ports: --- kV

**Polarity:** Positive & Negative

**Impulse Frequency:** 5 kHz

Impulse Wave-shape: 5/50 ns

**Burst Duration:** 15 ms

Burst Period: 300 ms

**Test Duration:** Not less than 1 min.

## 8.5.2. TEST INSTRUMENT

Immunity Shield Room								
Name of Equipment	Manufacturer Model Serial Number Calibration I							
Capacitor Clamp	KeyTek	CCL-4	9306412	01/17/2019				
Ultra Compact Simulator	EM TEST	UCS 500N7	P1552169754	04/19/2018				
Software	iec.control v5.4.4							

#### Note:

- 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
- 2. N.C.R.= No Calibration required

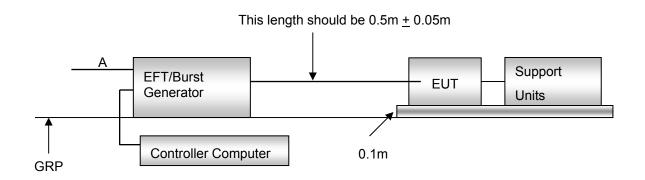
# 8.5.3. TEST PROCEDURE

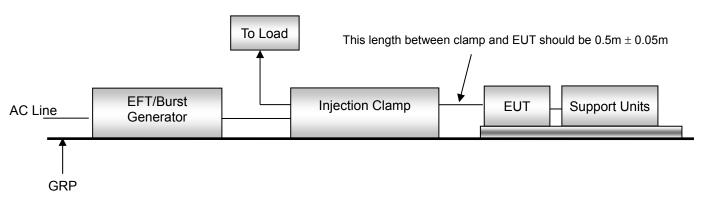
- a) Both positive and negative polarity discharges were applied.
- b) The length of the "hot wire" from the coaxial output of the EFT generator to the terminals on the EUT should not exceed 0.5 meter.
- c) The duration time of each test sequential was 1 minute.
- d) The transient/burst waveform was in accordance with IEC 61000-4-4, 5/50ns.



Page 58 of 77 Rev.00

#### 8.5.4. TEST SETUP





For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.

#### Note:

#### **TABLETOP EQUIPMENT**

The configuration consisted of a wooden table (0.1m high) standing on the Ground Reference Plane. The GRP consisted of a sheet of aluminum (at least 0.25mm thick and 2.5m square) connected to the protective grounding system. A minimum distance of 0.5m was provided between the EUT and the walls of the laboratory or any other metallic structure.

# FLOOR-STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC 61000-4-4 and its cables, were isolated from the Ground Reference Plane by an insulating support that is 0.1-meter thick. The GRP consisted of a sheet of aluminum (at least 0.25mm thick and 2.5m square) connected to the protective grounding system.



Page 59 of 77 Rev.00

# 8.5.5. TEST RESULTS

For Model: 500 BR

Temperature	25°C	Humidity	48% RH
Pressure	1028mbar	Tested By	Taiyu Cyu
Required Passing Performance	Criterion B	Test Mode	Full Load

Test Point	Polarity	Test Level (kV)	Performance Criterion	Result	Observation
L	+/-	1	⊠A □B	PASS	
N	+/-	1	⊠A □B	PASS	
PE	+/-	1	⊠A □B	PASS	
L+N	+/-	1	⊠A □B	PASS	
L+PE	+/-	1	⊠A □B	PASS	
N+PE	+/-	1	⊠A □B	PASS	
L+N+PE	+/-	1	⊠A □B	PASS	



Page 60 of 77 Rev.00

## **8.6. SURGE IMMUNITY TEST**

#### 8.6.1. TEST SPECIFICATION

Basic Standard: IEC 61000-4-5

Wave-Shape: Combination Wave

1.2/50 μs Open Circuit Voltage 8/20 μs Short Circuit Current

Test Voltage: AC Power Port~ line to line: 1kV, line to ground: 2kV

DC Power Port~ line to earth: --- kV

Signal and Telecommunication Ports ~ line to ground: ---kV

Surge Input/Output: AC Power Line: L-N \ L-PE \ N-PE

Generator Source Impedance: 2 ohm between networks

12 ohm between network and ground

**Polarity:** Positive/Negative

Phase Angle: 0° / 90° / 180° / 270°

Pulse Repetition Rate: 1 time / min. (maximum)

**Number of Tests:** 5 positive and 5 negative at selected points

## 8.6.2. TEST INSTRUMENT

Immunity Shield Room				
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due
CDN	EMC-PAPTNER	CDN-UTP8	CDN-UTP8-1504	05/26/2018
Ultra Compact Simulator	EM TEST	UCS 500N7	P1552169754	04/19/2018
Software	CE Ware 3.00b			

#### Note:

- 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
- 2. N.C.R. = No Calibration required



Page 61 of 77 Rev.00

#### 8.6.3. TEST PROCEDURE

a) For EUT power supply:

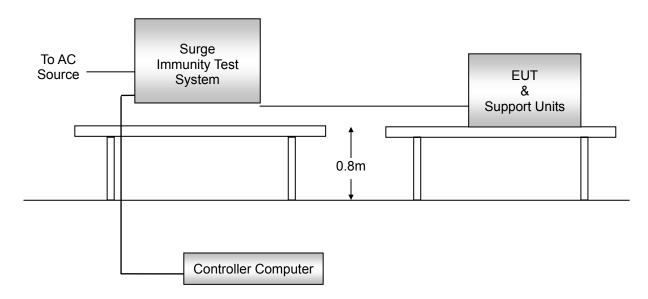
The surge is applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks was shorter than 2 meters in length.

- b) For test applied to unshielded un-symmetrically operated interconnection lines of EUT:

  The surge was applied to the lines via the capacitive coupling. The coupling / decoupling networks didn't influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling/decoupling networks was shorter than 2 meters in length.
- c) For test applied to unshielded symmetrically operated interconnection / telecommunication lines of EUT:

The surge was applied to the lines via gas arrestors coupling. Test levels below the ignition point of the coupling arrestor were not specified. The interconnection line between the EUT and the coupling/decoupling networks was shorter than 2 meters in length.

#### 8.6.4. TEST SETUP



For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.



Page 62 of 77 Rev.00

# 8.6.5. TEST RESULTS

For Model: 500 BR

Temperature	25°C	Humidity	48% RH
Pressure	1028mbar	Tested By	Taiyu Cyu
Required Passing Performance	Criterion B	Test Mode	Full Load

Test Point	Polarity	Test Level (kV)	Performance Criterion	Result	Observation
L - N	+/-	1	⊠A □B	PASS	
L – PE	+/-	2	⊠A □B	PASS	
N - PE	+/-	2	⊠A □B	PASS	



Page 63 of 77 Rev.00

# 8.7. CONDUCTED RADIO FREQUENCY DISTURBANCES (CS)

#### 8.7.1. TEST SPECIFICATION

Basic Standard: IEC 61000-4-6

Frequency Range: 0.15 MHz ~ 80 MHz

Field Strength: 3 Vrms

**Modulation:** 1kHz Sine Wave, 80%, AM Modulation

**Frequency Step:** 1 % of preceding frequency value

Coupling device: CDN-M3 (3 wires)

## 8.7.2. TEST INSTRUMENT

CS Test Site (IEC/EN 61000-4-6)				
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due
CDN	Frankonia	CDN M2+M3	A3011095	11/22/2018
Continuous Wave Simulator	EM TEST	CWS 500N1.4	P1247105414	11/22/2018
Couplihd/Decoupling Networks	FRANKONIA	CDN-RJ45	A3100030/2013	05/20/2018
EM Injection Clamp	FCC	F-203I-23MM	449	05/18/2018
6dB Attenuator	BIRD	75-A-FFN-06	0346	N.C.R
Software	CS-EN61000-4-6			

#### Note:

- 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
- 2. N.C.R.= No Calibration required



Page 64 of 77 Rev.00

#### 8.7.3. TEST PROCEDURE

The EUT shall be tested within its intended operating and climatic conditions.

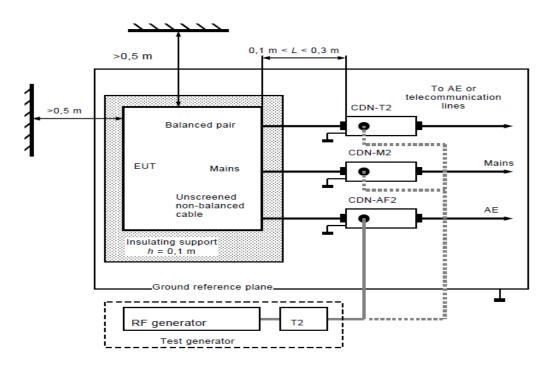
The test shell performed with the test generator connected to each of the coupling and decoupling devices in turn, while the other non-excited RF input ports of the coupling devices are terminated by a 50-ohm load resistor.

The frequency range was swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80 % amplitude. The signal was modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or the switch coupling devices as necessary. The sweep rate was  $1.5 \times 10^{-3}$  decades/s. Where the frequency range is swept incrementally, the step size was 1 % of preceding frequency value from 150 kHz to 80 MHz.

The dwell time at each frequency was less than the time necessary for the EUT to be exercised, and able to respond. Sensitive frequencies such as clock frequency(ies) and harmonics or frequencies of dominant interest, was analyzed separately.

Attempts were made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.

# **8.7.4. TEST SETUP**



Note:

- 1. The EUT is setup 0.1m above Ground Reference Plane
- 2. The CDNs and / or EM clamp used for real test depend on ports and cables configuration of EUT.

For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.

#### Note:

## TABLETOP AND FLOOR-STANDING EQUIPMENT

The equipment to be tested is placed on an insulating support of 0.1 meters height above a ground reference plane. All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meters and 0.3 meters from the projected geometry of the EUT on the ground reference plane.



Page 65 of 77 Rev.00

# 8.7.5. TEST RESULTS

For Model: 500 BR

Temperature	24°C	Humidity	45% RH
Pressure	1028mbar	Tested By	Taiyu Cyu
Required Passing Performance	Criterion A	Test Mode	Full Load

Frequency Band (MHz)	Field Strength (Vrms)	Cable	Injection Method	Perfor Crite	mance erion	Result	Observation
0.15 ~ 80	3	AC Power	CDN-M3	⊠A	□в	PASS	



Page 66 of 77 Rev.00

## 8.8. POWER FREQUENCY MAGNETIC FIELD

#### 8.8.1. TEST SPECIFICATION

Basic Standard: IEC 61000-4-8

Frequency Range: 50Hz

Field Strength: 1 A/m

**Observation Time:** 1 minute

**Inductance Coil:** Rectangular type, 1mx1m

#### 8.8.2. TEST INSTRUMENT

Immunity Shield Room				
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due
AC/DC CLAMP METER	PROVA	2003	02190104	03/14/2019
Magnetic generator	Schaffner	MFO 6501	154	N.C.R
Magnetic loops	Schaffner	INA 702	158	N.C.R

#### Note:

- 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
- 2. N.C.R.= No Calibration required

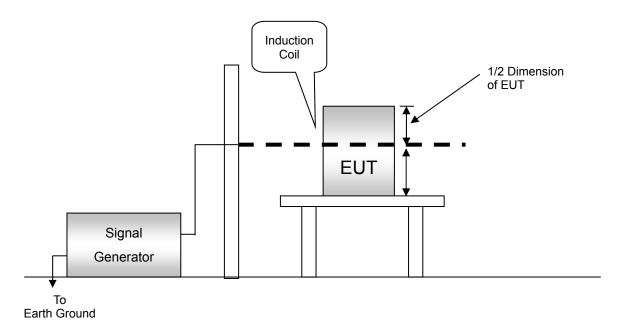
#### 8.8.3. TEST PROCEDURE

- a) The equipment is configured and connected to satisfy its functional requirements. It shall be placed on the GRP with the interposition of a 0.1m-thick insulating support.
- b) The equipment cabinets shall be connected to the safety earth directly on the GRP via the earth terminal of the EUT.
- c) The power supply, input and output circuits shall be connected to the sources of power supply, control and signal.
- d) The cables supplied or recommended by the equipment manufacturer shall be used. 1 meter of all cables used shall be exposed to the magnetic field.



Page 67 of 77 Rev.00

#### 8.8.4. TEST SETUP



For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.

#### Note:

## **TABLETOP EQUIPMENT**

The equipment shall be subjected to the test magnetic field by using the induction coil of standard dimension (1 m x 1 m). The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

#### FLOOR-STANDING EQUIPMENT

The equipment shall be subjected to the test magnetic field by using induction coils of suitable dimensions. The test shall be repeated by moving and shifting the induction coils, in order to test the whole volume of the EUT for each orthogonal direction. The test shall be repeated with the coil shifted to different positions along the side of the EUT, in steps corresponding to 50 % of the shortest side of the coil. The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.



Page 68 of 77 Rev.00

## 8.8.5. TEST RESULTS

For Model: 500 BR

Temperature	25°C	Humidity	47% RH
Pressure	1028mbar	Tested By	Taiyu Cyu
Required Passing Performance	Criterion A	Test Mode	Full Load

DIRECTION	Field Strength (A/m)	Performance Criterion	Result	Observation
X	1	⊠A □B	PASS	
Υ	1	⊠A □B	PASS	
Z	1	⊠A □B	PASS	



Page 69 of 77 Rev.00

## 8.9. VOLTAGE DIPS & VOLTAGE INTERRUPTIONS

#### 8.9.1. TEST SPECIFICATION

Basic Standard: IEC 61000-4-11

**Test duration time:** Minimum three test events in sequence

**Interval between event:** Minimum 10 seconds

**Phase Angle:** 0° / 45° / 90° / 135° / 180° / 225° / 270° / 315° / 360°

Test cycle: 3 times

#### 8.9.2. TEST INSTRUMENT

Immunity shielded room				
Name of Equipment Manufacturer Model Serial Number Calibra				Calibration Due
Ultra Compact Simulator	EM TEST	UCS 500N7	P1552169754	04/19/2018
Software	iec.control v5.4.4			

#### Note:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. N.C.R. = No Calibration Required.

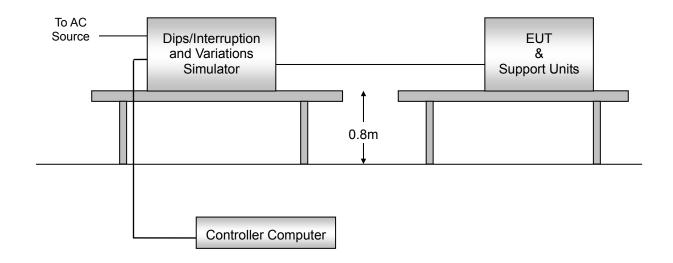
#### 8.9.3. TEST PROCEDURE

- a) The EUT and support units were located on a wooden table, 0.8 m away from ground floor.
- b) Setting the parameter of tests and then perform the test software of test simulator.
- c) Conditions changes to occur at 0 degree crossover point of the voltage waveform.
- d) Recording the test result in test record form.



Page 70 of 77 Rev.00

# 8.9.4. TEST SETUP



For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.

## 8.9.5. TEST RESULTS

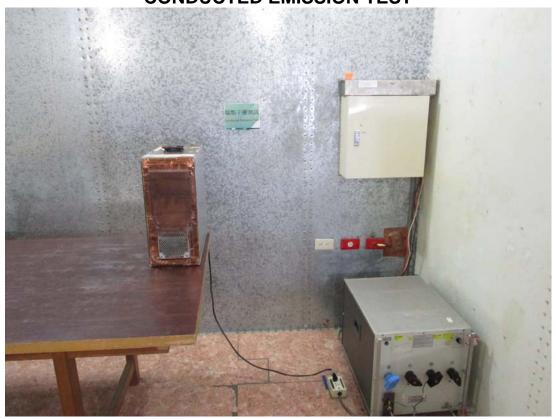
Environmental Conditions	25°C, 45% RH, 1028mbar	Test Mode	Full Load
Required Passing	Criterion B: >95% reduction 0.5 periods Criterion C: 30% reduction 25 periods & >95% reduction 250 periods		Taiyu Cyu

Test Power: 230Vac, 50Hz				
Item	Voltage (% Reduction)	Duration (Period)	Performance Criterion	Test Result
Voltage Dips	>95	0.5	⊠A □B □C	PASS
	30	25	⊠A □B □C	PASS
Voltage Interruption	>95	250	□A ⊠B □C	PASS



Page 71 of 77 Rev.00

# 9 PHOTOGRAPHS OF THE TEST CONFIGURATION CONDUCTED EMISSION TEST

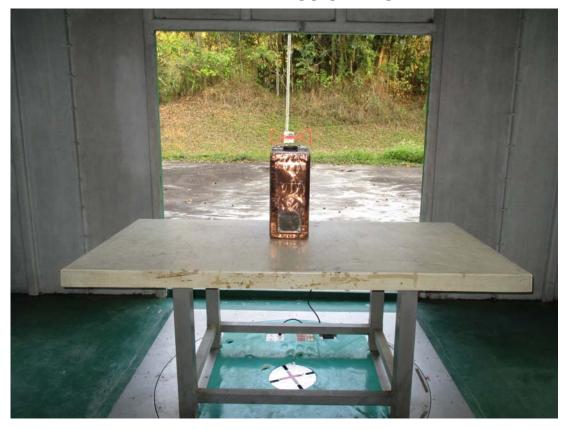






Page 72 of 77 Rev.00

# **RADIATED EMISSION TEST**







Page 73 of 77 Rev.00

# **HARMONICS TEST**



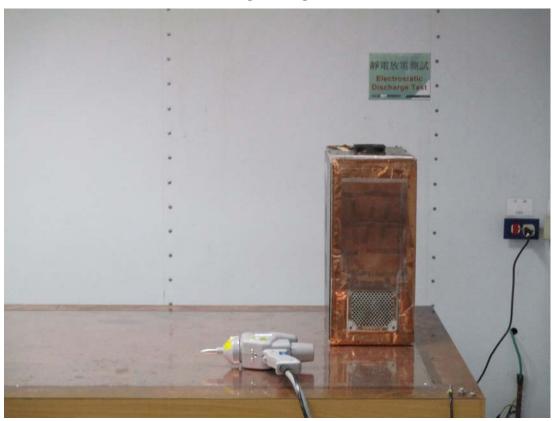
**FLICKER TEST** 



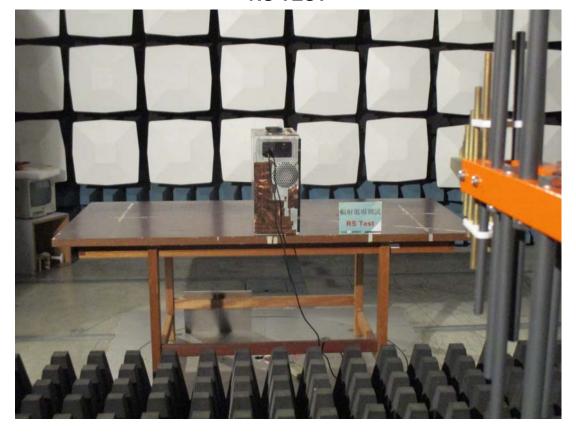


Page 74 of 77 Rev.00

# **ESD TEST**



**RS TEST** 





Page 75 of 77 Rev.00

# **EFT TEST**



**SURGE TEST** 



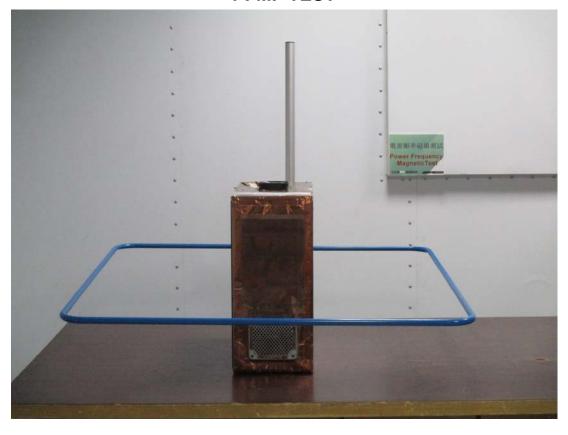


Page 76 of 77 Rev.00

# **CS TEST**



**PFMF TEST** 





Page 77 of 77 Rev.00

# **VOLTAGE DIPS / INTERRUPTIONS TEST**

